EMC Test Challenges for NASA’s James Webb Space Telescope

John McCloskey
Chief EMC Engineer
NASA Goddard Space Flight Center
Greenbelt, MD
<table>
<thead>
<tr>
<th>Acronym</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>CE</td>
<td>Conducted Emissions</td>
</tr>
<tr>
<td>CMCE</td>
<td>Common Mode Conducted Emissions</td>
</tr>
<tr>
<td>CS</td>
<td>Conducted Susceptibility</td>
</tr>
<tr>
<td>EMC</td>
<td>Electromagnetic Compatibility</td>
</tr>
<tr>
<td>EMI</td>
<td>Electromagnetic Interference</td>
</tr>
<tr>
<td>FFT</td>
<td>Fast Fourier Transform</td>
</tr>
<tr>
<td>FGS</td>
<td>Fine Guidance Sensor</td>
</tr>
<tr>
<td>GSFC</td>
<td>Goddard Space Flight Center</td>
</tr>
<tr>
<td>IEC</td>
<td>ISIM Electronics Compartment</td>
</tr>
<tr>
<td>IHR</td>
<td>ISIM Harness Radiator</td>
</tr>
<tr>
<td>ISIM</td>
<td>Integrated Science Instrument Module</td>
</tr>
<tr>
<td>JWST</td>
<td>James Webb Space Telescope</td>
</tr>
<tr>
<td>LISN</td>
<td>Line Impedance Simulation Network</td>
</tr>
<tr>
<td>NASA</td>
<td>National Aeronautics and Space Administration</td>
</tr>
<tr>
<td>MIRI</td>
<td>Mid Infrared Instrument</td>
</tr>
<tr>
<td>NIRCam</td>
<td>Near Infrared Camera</td>
</tr>
<tr>
<td>NIRSpec</td>
<td>Near Infrared Spectrometer</td>
</tr>
<tr>
<td>RE</td>
<td>Radiated Emissions</td>
</tr>
<tr>
<td>RMS</td>
<td>Root Mean Square</td>
</tr>
<tr>
<td>RS</td>
<td>Radiated Susceptibility</td>
</tr>
</tbody>
</table>

Introduction

- James Webb Space Telescope (JWST) will be the premier observatory of the next decade, serving thousands of astronomers worldwide.
- It will study every phase in the history of our Universe, ranging from the first luminous glows after the Big Bang, to the formation of solar systems capable of supporting life on planets like Earth, to the evolution of our own Solar System.
JWST’s science payload is ISIM (Integrated Science Instrument Module), which consists of four instruments:

- Fine Guidance Sensor (FGS)
- Mid-Infrared Instrument (MIRI)
- Near Infrared Camera (NIRCam)
- Near Infrared Spectrometer (NIRSpec)
EMC Challenges for JWST and ISIM

- Full EMC test at integrated observatory level is not practical
  - RF self-compatibility is all that will be verified at Observatory level
  - EMC verification had to be addressed at lower levels, e.g. ISIM and spacecraft
- Integrated payload test
  - Not a box, not an integrated observatory (for which criteria are defined)
  - Needed to re-evaluate test criteria (next slides)
- All instruments implement infra-red detectors
  - Operated at cryogenic temperatures (< 40 K) in on-orbit configuration
  - Electronics boxes inside IEC operate near 300 K
  - Cables must accommodate this thermal gradient
    - Implement wires and shields made with higher resistance conductors
    - Compromised performance and shielding effectiveness
- This test presented final opportunity to perform radiated testing on ISIM
  - Test was performed at ambient temperature (~300 K)
    - Not expected to affect the power quality or RE
    - Expected to affect the RS; detector response known to be temperature dependent
  - Intra-ISIM compatibility (i.e. instrument-to-instrument crosstalk) was evaluated during ISIM thermal vacuum testing with detectors operating at on-orbit temperatures
EMC Challenges for JWST and ISIM (cont.)

- EMI tests performed at instrument, subsystem, and/or unit level, based on MIL-STD-461C and MIL-STD-462:
  - Conducted Emissions
    - CE01/CE03
    - Common Mode Conducted Emissions (CMCE)
    - Inrush current
  - Conducted susceptibility
    - CS01/CS02
    - CS06
  - Radiated emissions
    - RE01
    - RE02
  - Radiated susceptibility
    - RS01
    - RS03

NO NEED TO REPEAT THESE TESTS AT ISIM LEVEL
EMC Challenges for JWST and ISIM (cont.)

- Re-Evaluated ISIM level test criteria:
  - Power Quality
    - Aggregate bus ripple
      - Time domain
      - Frequency domain
  - Transients
    - Turn-on
    - Turn-off
    - Operational (mechanism movements, heaters, etc.)
  - Aggregate Radiated Emissions (RE)
    - On-orbit configuration
    - Launch configuration
  - Aggregate Radiated Susceptibility (RS)
    - On-orbit configuration
    - Launch configuration
Power Quality Measurements

AGGREGATE BUS RIPPLE (ISIM Level)

\[ V = IZ_S \]

Power Quality Measurements with JWST Custom LISN
Power Quality Measurements with JWST Custom LISN (cont.)

Power Quality Measurements

- **Aggregate bus voltage ripple criteria:**
  - **Time domain**
    - JWST requirement at ISIM level
    - Limit: +/- 500 mV peak-to-peak (1 V peak-to-peak)
  - **Frequency-domain**
    - Not required; engineering data only
    - Easy to perform using oscilloscope with FFT capability
    - Measurements compared to CS01/CS02 limit applied at unit level

---

**JWST CS01/CS02 Limit**

![Diagram showing voltage levels and frequency ranges](image-url)
Power Quality Measurements (cont.)

- Aggregate bus voltage ripple results:
  - Time domain
    - Largest measured ripple was 168 mV p-p
    - Well under 1 V p-p requirement
  - Frequency-domain
    - Largest frequency-domain signal measured was 615 µVrms at ~64 MHz
    - Well under 1 Vrms requirement for CS01/CS02

---

AGGREGATE VOLTAGE RIPPLE FROM ISIM IS NOT EXPECTED TO POSE A PROBLEM AT INTEGRATED OBSERVATORY LEVEL
Power Quality Measurements (cont.)

- **Turn-on/turn-off transients criteria:**
  - Not required; engineering data only
  - “Get it for free” with oscilloscope and LISN already in setup
  - Compare measured transients to CS06 pulse applied at unit level
Power Quality Measurements (cont.)

- Turn-on transients

\[ \begin{align*}
28 \text{ V} & \quad \text{(common distribution point; seen by all other loads)} \\
V_D & \\
V_L & \quad \text{(when switch is closed at } t = 0, V_L \text{ will be pulled toward 0 V and will rise as } C_L \text{ charges)} \\
\end{align*} \]
Power Quality Measurements (cont.)

• Turn-off transients

When switch opens, inductor current will flow to other loads.
Power Quality Measurements (cont.)

- Turn-on/turn-off transients results:
  - Most transients were within CS06 pulse amplitude and duration
  - Worst case: transient that dropped bus potential by ~0.5 V for 25 msec
  - Bus potential was maintained well within the range of 22 to 35 VDC to which each electronics box was tested at unit level

TURN-ON/TURN OFF TRANSIENTS FROM ISIM ARE NOT EXPECTED TO POSE A PROBLEM AT INTEGRATED OBSERVATORY LEVEL
Radiated Testing – Antenna Selection

BICONICAL (a.k.a. “BOW TIE”)
Frequency range: 30 MHz – 200 MHz
Linearly polarized
Need horizontal and vertical polarizations at each position

CONICAL LOG SPIRAL (ETS Lindgren 3101)
Frequency range: 200 MHz – 1 GHz
Used outside of S-band notch
Circularly polarized
Measures both polarizations simultaneously
3 dB beamwidth of ~ 60 degrees

CONICAL LOG SPIRAL (ETS Lindgren 3102)
Frequency range: 1 GHz – 10 GHz
Used outside of S-band notch
Circularly polarized
Measures both polarizations simultaneously
3 dB beamwidth of ~ 60 degrees

DOUBLE-RIDGED GUIDE
Frequency range: 1 – 18 GHz
Used for S-band notch measurements
Linearly polarized
Need horizontal and vertical polarizations at each position
Aggregate Radiated Emissions

• Prior to delivery to ISIM, all instruments were tested for RE02 as part of their respective EMI test programs
• At ISIM level, the goal was to demonstrate that the aggregate radiated emissions were still within acceptable limits
• Criteria:
  – ISIM must not generate any emissions that could interfere with S-band receiver, which operates in frequency range of 2.0898521 - 2.0916521 GHz, limit of 13 dBµV/m
  – Outside of S-band, radiated emissions test provides a qualitative check of ISIM construction, e.g. that cables were built and terminated properly, boxes were bonded properly to structure, etc.

Aggregate Radiated Emissions (cont.)

• Mechanism Movements
  – Each instrument included a set of mechanisms (e.g. filter wheels, focus mechanisms, etc.)
    • Operated at the on-orbit temperatures below 40 K
    • Most mechanisms had limited allocations for operation at ambient temperature
  – Most sensitive victim that is being protected by RE test is S-band receiver
    • It was decided to perform all of the mechanism movements during the scans in the S-band notch in order to determine if any of the mechanism operations might pose a risk of interference with the S-band receiver.
  – Because mechanism movements are inherently non-continuous operations of finite time duration, the standard radiated emissions measurement technique was not considered sufficient for capturing emissions in the S-band notch due to mechanism operations
  – It was decided to use the FFT-based time domain scan capability of the EMI receiver in order to maximize the likelihood of capturing these emissions (recommended in the recently released MIL-STD-461G)
Aggregate Radiated Emissions (cont.)

- Antenna Positions (S-Band notch example)
Aggregate Radiated Emissions (cont.)

- All RE scans compliant
- Inside and outside S-band notch

**ALL SCANS SIMILAR**
Aggregate Radiated Susceptibility

- Test antennas placed to simulate radiated energy from direction of spacecraft
- By moving antenna back to distance of 2 m, entire IEC “cavity” could be illuminated with a single position (HUGE time savings)
Aggregate Radiated Susceptibility (cont.)

- Single antenna position to cover IEC cavity
Aggregate Radiated Susceptibility (cont.)

- Field pre-calibrated and corrected for probe locations
  - Distance from antenna (1.78 m to probes vs. 2 m to antenna)
  - Probes near edge of 3 dB beamwidth

- Pre-calibrations took 1 day; RS scans completed in 1 day
  - Real time levelling would likely have taken at least twice as long and posed higher risk of overtest
Aggregate Radiated Susceptibility (cont.)

• Adjustment of Field Levels for Ambient Operations
  – JWST on-orbit RS limit is 2 V/m, 14 kHz – 18 GHz
    • Applies at on-orbit operating temperatures of < 40 K
    • ISIM level test was to be performed at room ambient temperature (~300 K).
  – Prior to ISIM tests, detector susceptibility at ambient vs. cryo temperatures was characterized using CS114 test method of MIL-STD-461F
    • For given culprit signal, signal-to-noise ratio at room temperature was ~10x lower than at cryo temperature
    • At either temperature, amplitude of coupled signal was approximately proportional to square of the voltage/current of applied signal
Aggregate Radiated Susceptibility (cont.)

- **Adjustment of Field Levels for Ambient Operations (cont.)**
  - Equivalent applied field level at room temperature is $\sqrt{10}$x higher than desired level at cryo temperature
    - 2 V/m at cryo temperature converts to 6.3 V/m at room temperature
  - In order to characterize the radiated susceptibility at on-orbit operating temperature, it was decided to apply pre-calibrated electric field intensities of the following levels:
    - 6.3 V/m (full level)
    - 3.1 V/m (6 dB down from full level)
    - 2.0 V/m (10 dB down from full level)
Aggregate Radiated Susceptibility (cont.)

- RS criteria for detector subsystems
  - 10 µsec pixel period (100 kHz sampling rate)
  - To first order, noise is determined by taking statistics on pixel data
  - Any frequency above 50 kHz will be under sampled (RS at ISIM level applied >30 MHz)
  - Susceptibility at any given frequency will manifest itself as the total energy integrated over a pixel period
  - At a susceptible frequency, an unmodulated (continuous wave) signal will produce an approximately equally shifted signal in all pixels
  - Performing statistics on such frames may show a shifted mean, but the standard deviation will not look much different from a non-RS frame
  - Observed during instrument/subsystem level tests
Aggregate Radiated Susceptibility (cont.)

- RS criteria for detector subsystems (cont.)
  - Pulse modulation of RS signals specified by MIL-STD-461F, section 4.3.10.4.2:
    - 1 kHz pulse modulation
    - 50% duty cycle (500 µsec on, 500 µsec off)
  - At a susceptible frequency, a pulse modulated signal will produce a frame with groups of 50 “noisy” pixels interspersed with groups of 50 “clean” pixels
  - Susceptibility at any given frequency is much more obvious
  - Also observed during instrument/subsystem level tests
Aggregate Radiated Susceptibility (cont.)

- RS criteria for detector subsystems (cont.)
  - Modulation example

Switching to next frequency + settling time (~1 second, ~200 rows)

Modulated signal applied for 1 second dwell time at each frequency (~200 rows)

50 pixels ON, 50 pixels OFF

Aggregate Radiated Susceptibility (cont.)

• Detector subsystems showed susceptibilities at instrument/subsystem level
  – At frequencies in 10s of MHz range
  – Likely resonant lengths of exposed cables (4-6 m)

• Exposed cable lengths are different in integrated ISIM configuration
  – 0.6 – 0.7 m
  – Susceptibilities expected to shift to 100 – 300 MHz range
Aggregate Radiated Susceptibility (cont.)

• Results
  – No susceptibilities observed at 2.0 V/m (compliant with JWST requirement)
  – Some susceptibilities observed at 6.3 V/m level
    • All in frequency range of 100 - 300 MHz (as predicted)
    • No susceptibility at 6.3 V observed above 300 MHz
  – Main culprit on spacecraft is S-band transmitter operating at 2.27 GHz
  – Levels of 2 V/m and higher are achievable only from intentional transmitters (not from accidental emissions from electronics)

RISK OF POTENTIAL INTERFERENCE TO ISIM FROM SPACECRAFT HAS BEEN ADDRESSED AS THOROUGHLY AS POSSIBLE

>12 YEARS IN THE MAKING
They tested like eight hundred…
Summary

• The ISIM EMC Test presented a number of unique challenges
• Test criteria had to be re-examined, and in some cases, test methods had to be developed for them
• All test objectives were met, and it can be stated without hesitation that ISIM passed the test with flying colors
• Moreover, despite a few setbacks, the test was completed in 8.5 days of the 10 days allocated
Acknowledgments

- Many thanks to everyone on the NASA/GSFC EMI test team and the JWST/ISIM project team who contributed to the planning and execution of this test and helped to make it the amazing success that it was
- Additional thanks:
  - John Lichtig of Lichtig EMC Consultants for his tireless efforts on many levels
  - Ken Javor of EMC Compliance for his consistently excellent technical guidance and relentless proofreading
- This test embodied and epitomized everything that is meant by the term “team effort”
- Leading this effort will certainly go down as one of the highlights of my career, and it was a tremendous honor to be part of it
Thanks for attending!

Don’t miss our Test Bootcamp!  
November 16, 2016  
www.emclive2016.com